

AO4801 30V P-Channel MOSFET

General Description

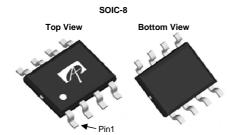
The AO4801 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications. It may be used in a common drain arrangement to form a bidirectional blocking switch.

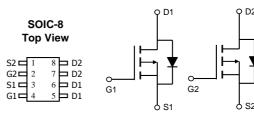
Product Summary

 $\begin{array}{lll} V_{DS} & -30V \\ I_{D} & (at \ V_{GS}{=}{-}10V) & -5A \\ R_{DS(ON)} & (at \ V_{GS}{=}{-}10V) & < 48m\Omega \\ R_{DS(ON)} & (at \ V_{GS}{=}{-}4.5V) & < 57m\Omega \\ R_{DS(ON)} & (at \ V_{GS}{=}{-}2.5V) & < 80m\Omega \end{array}$

100% UIS Tested 100% R_g Tested







Absolute Maximum Ratings T _A =25℃ unless otherwise noted						
Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V _{DS}	-30	V		
Gate-Source Voltage		V _{GS}	±12	V		
Continuous Drain	T _A =25℃		-5			
Current	T _A =70℃	ID	-4	A		
Pulsed Drain Current C		I _{DM}	-28			
Avalanche Current ^C		I _{AS} , I _{AR}	11	A		
Avalanche energy L=0.3mH ^C		E _{AS} , E _{AR}	18	mJ		
	T _A =25℃	ь	2	W		
Power Dissipation ^B	T _A =70℃	P_{D}	1.3	VV		
Junction and Storage Temperature Range		T _I , T _{STG}	-55 to 150	Ϋ́		

Thermal Characteristics							
Parameter	Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	Р	48	62.5	€\M		
Maximum Junction-to-Ambient AD	Steady-State $R_{\theta JA}$		74	90	€\M		
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	32	40	€/M		



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	I _D =-250μA, V _{GS} =0V				V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V				-1	
			T _J =55℃			-5	μΑ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±12V	V _{DS} =0V, V _{GS} = ±12V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=-250\mu A$		-0.5	-0.9	-1.3	V
$I_{D(ON)}$	On state drain current	V _{GS} =-4.5V, V _{DS} =-5V		-28			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =-10V, I_D =-5A			40	48	mΩ
			T _J =125℃		48	60	11152
		V_{GS} =-4.5V, I_{D} =-3.5A			45	57	mΩ
		V_{GS} =-2.5V, I_{D} =-2.5A		60	80	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-5A		18		S	
V_{SD}	Diode Forward Voltage	$I_S=-1A, V_{GS}=0V$		-0.7	-1	V	
Is	Maximum Body-Diode Continuous Current					-2.5	Α
DYNAMIC	PARAMETERS						
C_{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-15V, f=1MHz			645		pF
Coss	Output Capacitance				80		pF
C_{rss}	Reverse Transfer Capacitance				55		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		4	7.8	12	Ω
SWITCHI	NG PARAMETERS						
Q _g (4.5V)	Total Gate Charge	V _{GS} =-4.5V, V _{DS} =-15V, I _D =-5A			7		nC
Q_{gs}	Gate Source Charge				1.5		nC
Q_{gd}	Gate Drain Charge				2.5		nC
t _{D(on)}	Turn-On DelayTime				6.5		ns
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-15V, R_L =3 Ω , R_{GEN} =6 Ω			3.5		ns
t _{D(off)}	Turn-Off DelayTime				41		ns
t _f	Turn-Off Fall Time				9		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =-5A, dI/dt=100A/μs			11		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=-5A$, $dI/dt=100A/\mu s$		3.5		nC	

A. The value of R_{8JA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using \leqslant 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150$ °C. Ratings are based on low frequency and duty cycles to keep initial $T_J=25$ °C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse ratin g.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

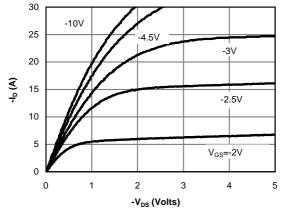


Fig 1: On-Region Characteristics (Note E)

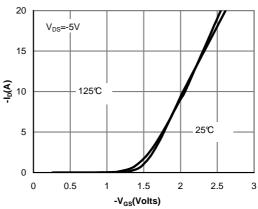


Figure 2: Transfer Characteristics (Note E)

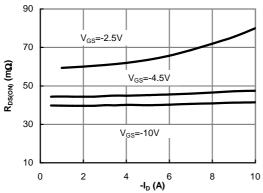


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

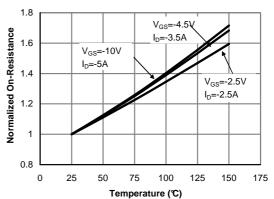


Figure 4: On-Resistance vs. Junction Temperature (Note E)

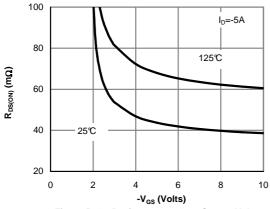


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

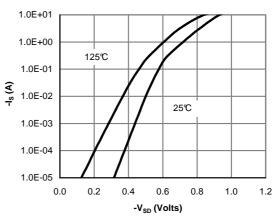


Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

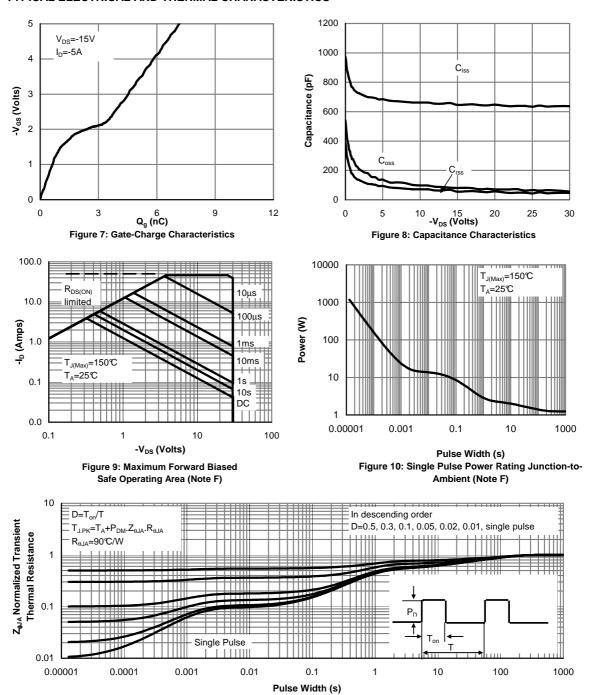
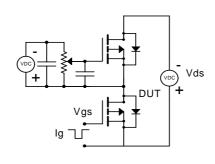
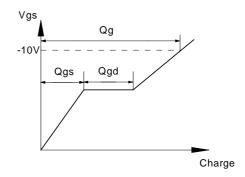


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

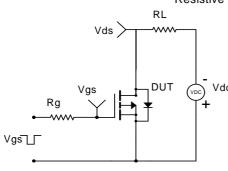


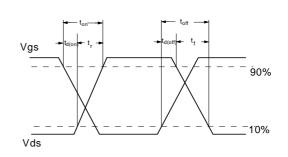
Gate Charge Test Circuit & Waveform



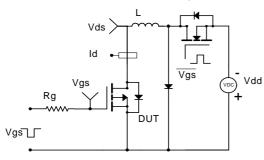


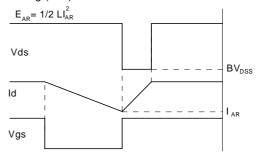
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

